## Applicant(s)/Patent Under Application/Control No. Reexamination 10/714,305 CHANG ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1756 Daborah Chacko-Davis **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-2002/0001957 01-2002 Kim et al. 438/694 Α US-2004/0018742 01-2004 He et al. 438/710 В С US-US-D US-Ε US-F US-G US-Н US-1 US-J US-K US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Country Code-Number-Kind Code Name Classification MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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